

Growth and Characterization of Copper Indium Diselenide

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CuInSe₂ thin films were prepared on Ti plates by electrodeposition from an aqueous solution containing CuCl₂, InCl₃ and SeO₂. The deposition was carried out at -0.5V Vs SCE. X-ray diffraction and Scanning electron microscopy have been used to study the crystallographic and morphological properties of the samples. Effects of annealing in air have also been monitored. Apparent bulk structure changes have been observed during annealing. Annealing of films at 350 °C was found to result in the formation of CuInSe₂ films having a chalcopyrite structure, indicating that the samples are of good quality.